


Search Notes 	Application/Control No. 10551585	Applicant(s)/Patent Under Reexamination LEACH ET AL.
	Examiner HIEN NGUYEN	Art Unit 3768

SEARCHED			
Class	Subclass	Date	Examiner
600	410	2/9/2010	HN

SEARCH NOTES		
Search Notes	Date	Examiner
East Search (inventor search, compar\$3 with imag\$3 with (determin\$3 or identify) with similar\$3 with feature\$1, (first adj image\$1) same (boundar\$2 or edge\$1) same segment\$3 same (second adj image\$1) same (detect\$3 or defin\$3) vector)	2/4/2010	HN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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